## Notice of References Cited Application/Control No. 10/585,047 Examiner JOHN K. KIM Applicant(s)/Patent Under Reexamination LUTZ ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-6,476,535	11-2002	Oohashi et al.	310/263	
*	В	US-6,424,072	07-2002	Armiroli et al.	310/263	
*	С	US-5,708,318	01-1998	Fudono, Kiyoshi	310/263	
*	D	US-2002/0096965	07-2002	Ikeda et al.	310/263	
*	Е	US-2003/0137214	07-2003	Ishizuka et al.	310/263	
	F	US-				
	G	US-				
	Н	US-				
	I	US-				
	J	US-				
	K	US-				
	L	US-				
	М	US-				

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.